Introduction to Reliability Engineering

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Basic Reliability Concepts

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Background Reliability Function Relationship to CDF & PDF Mean/Residual Time-To-Failure Failure &Hazard Rate Bathtub Curve Decreasing Failure Rate Constant Failure Rate Increasing Failure Rate Comprehensive Example

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Why is Reliability Important?

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Reliability is important because things fail. Failures occur due to many reasons.

- Causes of failure include poor design, faulty manufacturing or construction, poor maintenance, inadequate inspection, environmental stresses, and human error.
- The impact of a failure can range from minor inconveniences and costs to personal injury or death, and significant economic losses.

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Why is Reliability Important

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- Generally, failure can be viewed as a culmination of a progressive degradation process.
- > In theory, if we understood the physics and chemistry associated with failure processes, then failures could be predicted with certainty.
- In practice, we have limited understanding of the physical and chemical processes that cause failure, and the randomness of external events. Thus, failures appear to be random.
- > Although appear to be random, they do exhibit some pattern that can be modeled using probability, i.e., we can predict failures statistically.

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Definition of Reliability

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- Reliability is the probability that a product will operate or a service will be provided properly for a specified period of time (known as the design life) under the intended operating conditions (designated temperature, load, speed, etc.) without failure.
- Reliability Engineering attempts to characterize, measure, and analyze system failures in order to improve their operational use to reduce the likelihood of unexpected failures, and downtime, thereby increasing availability.

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Definition of Reliability

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- Reliability requires a clear definition of the following aspects:
 - Meaning of failure, in terms of an observable description of functionality or performance.
 - Units of time e.g., hours, days, cycles (aircraft take-off, cruise, and landing).
 - Normal operating conditions, this includes factors such as load environment (temperature, vibration, altitude).

Improving Reliability

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- > One can often improve reliability in several
 - Increasing the redundancy or duplication.
 - Designing excess strength into
 - Derating; operating a system below its rated stress/loading level.
 - · Reducing the complexity and number of components in a system.

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Reliability Function

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- ightharpoonup Suppose n_o identical components are tested under their designed operating conditions. Let us assume that by some time t, $n_{
 m f}(t)$ failed components, and $n_{\mathrm{s}}(t)$ surviving components such that $n_{\rm f}(t) + n_{\rm S}(t) = n_{\rm o}$
- \triangleright Reliability at time t, R(t), is defined as

$$R(t) = \frac{n_s(t)}{n_s(t) + n_f(t)}$$

Reliability Function

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> If T is a random variable denoting the time to failure, then the reliability function at time \boldsymbol{t} can be expressed as;

$$R(t) = \mathbb{P}(T > t)$$

> Reliability is related to the cumulative probability function

$$F(t) = 1 - R(t) = \mathbb{P}(T < t)$$

► In fact, R(0)=1 and $\lim_{t\to\infty} R(t)=0$



Probability of Surviving

Reliability, CDF, & PDF

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 \succ If \emph{T} has a probability density function f(t), then

$$R(t) = 1 - F(t) = 1 - \int_0^{t'} f(t) dt$$
$$f(t) = -\frac{dR(t)}{dt} \circ O$$

ightharpoonup Also since, R(t) = 1 - F(t)

$$R(t) = \int_{t'}^{\infty} f(t) \, \mathrm{d}t$$

$$F(t) = \int_0^{t'} f(t) \, \mathrm{d}t$$

Example: Reliability Function

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> Given the following PDF of the time-to-failure of a compressor, which we will denote as T, what is the reliability for 100-hr of operating life.

$$f(t) = \begin{cases} \frac{0.001}{(0.001 \ t + 1)^2} & t \ge 0\\ 0 & \text{otherwise} \end{cases}$$

$$R(t) = \int_{t'}^{\infty} f(t) dt = \int_{100}^{\infty} \frac{0.001}{(0.001 t + 1)^2} dt$$

$$R(100) = \frac{-1}{(0.001 t + 1)} \Big|_{100}^{\infty} = \frac{-1}{\infty} - \frac{-1}{(0.001)(100) + 1} = 0.909$$

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Example: Reliability Function

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ightharpoonup Probability that a failure occurs within the interval of time $\left[10,100\right]$ can be found using the following expression.

$$\mathbb{P}\{10 \leq 100\} = R(10) - R(100)$$

$$=\frac{1}{(0.01)+1}-\frac{1}{(0.1)+1}=0.081$$

Mean Time to Failure

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- One of the key measures of a system's reliability is the MTTF.
 - MTTF is usually used when the system is nonrepairable.
 - For repairable systems, the failure time between two successive failures is usually referred to as MTBF (B→Between)
- Consider n identical nonrepairable systems and their time to failure are given by t₁, t₂,...,t_n. Then the mean time to failure is given as,

$$\widehat{MTTF} = \frac{1}{n} \sum_{i = 5k}^{n} t_{i}$$

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Mean Time to Failure

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If t is a random variable representing time to failure, then the Mean-Time-To-Failure, MTTF can be defined as follows:

$$MTTF = \mathbb{E}[T] = \int_0^\infty t \, f(t) dt \, \circ \, \mathbf{O} \, \mathbf{O} \, \mathbf{u} = \int_0^\infty x \, f(x) \, dx$$

 \succ Another measure that is often used to describe the distribution of the time to failure is its variance σ^2

failure is its variance
$$\sigma^2$$

$$\sigma^2 = \int_0^\infty (t - MTTF)^2 f(t) dt \quad \text{o} \quad \text{o} \quad \sigma^2 = \int_0^\infty (x - \mu)^2 f(x) dx$$

$$\sigma^2 = \int_0^\infty t^2 f(t) dt - (MTTF)^2$$

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Mean Time to Failure

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- > MTTF can also be express in terms of the integral of reliability
- ightharpoonup Recall that f(t) = dF(t)/dt = -dR(t)/dt, thus,

$$MTTF = \int_0^\infty t \times \left(-\frac{dR(t)}{dt} \right) dt$$

Using integration by parts, we see that

$$MTTF = -t R(t) \Big|_0^{\infty} + \int_0^{\infty} R(t) dt$$

• Since $R(\infty) = 0$ and R(0) = 1, we have,

$$MTTF = \int_0^\infty R(t) dt$$

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Residual MTTF

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➢ If an equipment has been operating for some time ,T₀, we can still calculate its residual MTTF using the condition reliability function R(t|T₀).

$$MTTF(T_0) = \int_{T_0}^{\infty} R(t|T_0) d(t)$$

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Conditional Reliability

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 \succ We define conditional reliability as the reliability of a component given that it has operated for time T_0 .

$$\begin{split} R(t|T_0) &= \Pr\{T > t + T_0|T > T_0\} \\ &= \frac{\Pr\{(T > T_0 + t) \cap (T > T_0)\}}{\Pr\{T > T_0\}} \\ &= \frac{\Pr\{(T > T_0 + t)\}}{\Pr\{T > T_0\}} \\ &= \frac{R(T_0 + t)}{R(T_c)} \end{split}$$

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Residual MTTF

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 \succ If an equipment has been operating for some time T_0 , we can still calculate its **residual** MTTF using the condition reliability function $R(t|T_0)$.

$$\begin{split} MTTF(T_0) &= \int\limits_{T_0}^{\infty} R(t|T_0) \, \mathrm{d}(t) \\ &= \int\limits_{T_0}^{\infty} \frac{R(t+T_0)}{R(T_0)} \, \mathrm{d}(t+T_0) \\ &= \frac{1}{R(T_0)} \int\limits_{T_0}^{\infty} R(t') \, \mathrm{d}t' \end{split}$$

where $t' = t + T_0$

Example: Residual MTTF

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ightharpoonup Consider the following reliability function

$$R(t) = e^{-0.002 \, t}$$

Calculate the MTTF

$$\begin{split} MTTF &= \int_0^\infty R(t) \, \mathrm{d}t \\ MTTF &= \int_0^\infty e^{-0.002 \, t} \mathrm{d}t = \frac{e^{-0.002 \, t}}{-0.002} \Big|_0^\infty \\ &= \frac{-e^{-\infty}}{0.002} - \frac{-1}{0.002} = \frac{1}{0.002} = 500 \, hr \end{split}$$

Failure/Hazard Rate

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> Probability of failure of a component in a given time interval [t₁, t₂] can be expressed as follows;

$$\int_{t_1}^{t_2} f(t) dt = R(t_1) - R(t_2)$$

$$\begin{split} \int_{t_1}^{t_2} f(t) \, \mathrm{d}t &= F(t_2) - F(t_1) \\ &= [1 - R(t_2)] - [1 - R(t_1)] \\ &= R(t_1) - R(t_2) \end{split}$$

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Failure/Hazard Rate

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> Probability of failure of a component in an time $[t_1, t_2]$ can be expressed as;

$$\int_{t_1}^{t_2} f(t) \, \mathrm{d}t = R(t_1) - R(t_2)$$

Failure Rate is defined as the probability that a failure occurs within the interval $[t_1,t_2]$, given that no failure occurred prior to t_1 ,

$$\frac{R(t_1) - R(t_2)}{(t_2 - t_1)R(t_1)}$$

ightharpoonup By replacing t_1 and t_2 with t and $t+\Delta t$,

$$\frac{R(t) - R(t + \Delta t)}{\Delta t R(t)}$$
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Failure/Hazard Rate

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 \blacktriangleright The Hazard Rate Function is defined as the limit of the failure rate as Δt approaches zero, i.e., it is the instantaneous Failure Rate.

$$\lambda(t) = h(t) = \lim_{\Delta t \to 0} \frac{R(t) - R(t + \Delta t)}{\Delta t R(t)} = \frac{f(t)}{R(t)}$$

Important remark:
$$f(t) = \frac{-d \ R(t)}{dt}$$

$$\lambda(t) = -\frac{1}{R(t)} \frac{d \ R(t)}{dt}$$

$$R(t) = \exp\left[-\int_0^{t'} \lambda(t) \ dt\right]$$

$$\frac{\int_0^1 dx = \ln(x)}{\ln(R(t)) = -\int_0^1 \lambda(t) \ dt}$$

Failure/Hazard Rate

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> Another useful function is the Average Hazard Rate, denoted as $AFR(t_1,t_2)$, and defined as,

$$\begin{split} \text{AFR}(t_1, t_2) &= \frac{1}{t_2 - t_1} \int_{t_1}^{t_2} \lambda(t') \; dt' \\ &= \frac{\ln R(t_1) - \ln R(t_2)}{t_2 - t_1} \end{split}$$

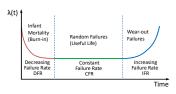
ightharpoonup If $t_1=0$ and $t_2=t$, then AFR can be written as follows:

$$AFR(t) = \frac{-\ln R(t)}{t}$$

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Bathtub Curve

The bathtub curve provides a general description of the hazard function across the life cycle of a product. It is comprised of 3 main regions.



Bathtub Curve - DFR

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- New units experience a high failure rates at the beginning of their use which then decreases over time, hence the term decreasing failure rate, DFR. This phase is known as infant mortality.
 - Typically results from manufacturing defects, cracks, poor workmanship, quality control, defective parts, contamination.
 - Can be reduced through burn-in testing where units are subjected to slightly more severe conditions than those encountered under normal operation.

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Bathtub Curve - CFR

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- The failure rate begins to level for a period of time which is characterized by a constant failure rate (CFR). In this region, failures are random and do not follow a predictable pattern.
 - This phase is typically referred to as the "useful life".
 - Events are often "Act of God".
 - Failure may be caused by random loads, human error, or chance.
 - This phase can be reduced by redundancy or excess strength.

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Bathtub Curve - IFR

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- The third region also known as the wear-out phase is characterized by an increasing failure rate (IFR). Failures in this phase are no longer characterized by being random and are mostly due to aging and wear
 - Typical causes of failure in this phase are fatigue due to cyclic loading, wear, corrosion.
 - Can be reduced through derating, preventive maintenance, parts replacement, condition monitoring using sensor technology

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Bathtub Curve (Summary)



	Characterized By	Caused By	Reduced By
Burn-in	DFR	Manufacturing defects: Welding flaws, defective parts, poor quality/workmanship, contamination.	Burn-in testing, screening, acceptance testing, quality control
Useful Life	CFR	Environment, random loads, human error, chance events	Redundancy, excess strength
Wear-out	IFR	Fatigue, corrosion, aging, cyclic loading	Derating, part replacement, preventive maintenance

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Section Summary

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Reliability and its Important

Mathematical Definition of Reliability function

Relation to CDF and PDF

Defined MTTF (Mean time to failure)

Residual MTTF & Conditional Reliability

Defined failure/hazard rate

Hazard rate function of reliability

Bathtub curve

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Knowledge Check



> A company manufactures widgets. The time to failure in years of these widgets has the following PDF.

$$f(t) = \frac{200}{(t+10)^3}$$
 for $t \ge 0$

a) Derive the reliability function and determine the reliability for the first year of operation.

$$R(t) = \int_{t'}^{\infty} f(t) dt = 200 \int_{t'}^{\infty} \frac{1}{(t+10)^3} dt$$
$$= \frac{-200}{2 \times (t+10)^2} \Big|_{t'}^{\infty} = 0 - \frac{-100}{(t'+10)^2} = \frac{100}{(t'+10)^2}$$

$$R(1) = \frac{100}{(1+10)^2} = 0.826$$

Knowledge Check

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 \succ The time to failure in years of these widgets has the following PDF.

$$f(t) = \frac{200}{(t+10)^3} \quad \text{for } t \ge 0$$

b) Computer the MTTF.

$$MTTF = \int_0^\infty R(t) dt = \int_0^\infty \frac{100}{(t+10)^2} dt$$
$$= \frac{-100}{(t+10)^1} \Big|_0^\infty = 10 \text{ years}$$

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Knowledge Check

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 $\,\succ\,$ The time to failure in years of these widgets has the following PDF.

$$f(t) = \frac{200}{(t+10)^3} \quad \text{for } t \ge 0$$

c) What is the design life for a reliability of 0.95?

$$R(t) = \frac{100}{(t+100)^2} = 0.95 \implies \text{Solve for } t$$

$$t = \sqrt{\frac{100}{0.95}} - 10 = 0.26 \, \text{years}$$

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Knowledge Check

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 \succ The time to failure in years of these widgets has the following PDF.

$$f(t) = \frac{200}{(t+10)^3} \quad \text{for } t \ge 0$$

d) Is the failure rate DFR, CFR, IFR?

Failure rate is decreasing, DFR, because $\lambda(0)=0.2$ and $\lambda(t o \infty)=0$

$$\lambda(t) = \frac{f(t)}{R(T)} = \frac{200}{(t+10)^3} / \frac{100}{(t+10)^2} = \frac{2}{t+10}$$

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Knowledge Check

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 $\, \boldsymbol{\succ} \,$ The time to failure in years of these widgets has the following PDF.

$$f(t) = \frac{200}{(t+10)^3} \quad \text{for } t \ge 0$$

e) Will a one year burn-in period improve the reliability in part (a)? Calculate the new reliability.

$$R(1|1) = \frac{R(1+1)}{R(1)} = \frac{100}{(2+10)^2} / \frac{100}{(1+10)^2}$$
$$= \frac{11^2}{12^2} = 0.84$$